Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/682,249	TAKAHASHI ET AL.
	Examiner	Art Unit
	Khanh V. Nguyen	2817

SEARCHED			
Class	Subclass	Date	Examiner
330	279	12/29/2004	NKV
330	285	12/29/2004	NKV
330	296	12/29/2004	NKV
455	126	12/29/2004	NKV
330	129	6/13/2005	NKV
455	232.1	6/13/2005	NKV

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
CLASSES	ABOVE	6/13/2005	NKV

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	6/10/2005	NKV